

Notice of References Cited

Application/Control No.

10/762,480

Applicant(s)/Patent Under
Reexamination
OTAKE ET AL.

Examiner

Rodney Amadiz

Art Unit

2629

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0166829	08-2004	Nakae et al.	455/403
*	B	US-2005/0188001	08-2005	Shiono et al.	709/200
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	J	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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